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Currently, Unmanned Air Vehicles (UAVs) are too large to penetrate buildings for situational awareness and reconnaissance, emplace important sensors, and sample and return material. While a variety of Micro Air Vehicles have been built and flown that use propellers and flapping wings for lift generation, Nano Air Vehicles (NAVs), defined as weighing less than 10 grams with wingspans less than 7.5 cm, have yet to be flown. NAV-scale actuators and wings with the requisite range of motion, power, and efficiency do not exist. In this project, we used a newly developed micromachining process based on Inductively Coupled Plasma Reactive Ion Etching (ICP-RIE), for PZT chips to fabricate novel, high performance actuators for NAVs. A novel T-beam actuator was fabricated using ICP-RIE etching from the front of a bulk PZT chip. Masked electrode deposition created active and passive regions in the PZT structure. With a T-shaped cross section, and bottom and top flange and web electrodes, a cantilevered beam can bend in-plane and out-of-plane with bimorph actuation in both directions. One of these T-beam actuators was fabricated and experimentally tested. An experimentally validated model predicted that the cross-section geometry can be optimized to produce higher displacement and blocking force.

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<thead>
<tr>
<th>a. REPORT</th>
<th>b. ABSTRACT</th>
<th>c. THIS PAGE</th>
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Abstract

Currently, Unmanned Air Vehicles (UAVs) are too large to penetrate buildings for situational awareness and reconnaissance, emplace important sensors, and sample and return material. While a variety of Micro Air Vehicles have been built and flown that use propellers and flapping wings for lift generation, Nano Air Vehicles (NAVs), defined as weighing less than 10 grams with wingspans less than 7.5 cm, have yet to be flown. NAV-scale actuators and wings with the requisite range of motion, power, and efficiency do not exist. In this project, we used a newly developed micromachining process based on Inductively Coupled Plasma Reactive Ion Etching (ICP-RIE), for PZT chips to fabricate novel, high performance actuators for NAVs. A novel T-beam actuator was fabricated using ICP-RIE etching from the front of a bulk PZT chip. Masked electrode deposition created active and passive regions in the PZT structure. With a T-shaped cross-section, and bottom and top flange and web electrodes, a cantilevered beam can bend in-plane and out-of-plane with bimorph actuation in both directions. One of these T-beam actuators was fabricated and experimentally tested. An experimentally validated model predicted that the cross-section geometry can be optimized to produce higher displacement and blocking force.
1 INTRODUCTION

Piezoelectric actuators are used for many applications, including micropositioning systems, camera auto-focus lenses, structural vibration control, and control surfaces. Most piezoelectric actuators use Lead Zirconate Titanate (PZT) because it provides large piezoelectric and electromechanical coupling factors. To produce reasonable motion, however, the piezoelectric strain must be amplified. Stack actuators [1],[2],[3] produce larger motions by stacking electroded thin PZT disks and actuating through the thickness. In this case, the material poling, applied voltage and displacement are all in the same direction. This makes use of the $d_{33}$ piezoelectric coefficient which is much larger than the $d_{31}$ coefficient ($\sim 1/3$ of $d_{33}$) used in unimorph or bimorph actuators. In unimorph/bimorph actuators, two layers of material are separated by an electrode [3],[4],[5],[6]. The unimorph has one PZT layer poled through the thickness and a passive layer. The PZT layer expands through the thickness and contracts longitudinally when an electric field is applied. The longitudinal contraction causes the unimorph to bend due to the constraining passive layer. The bimorph substitutes a second active PZT layer for the passive layer. This produces maximum transverse displacement because each layer can be used with maximum applied field in the direction of poling. The maximum applied field in the direction opposite poling is limited to $\sim 1/3$ of the positive field to prevent depoling of the PZT. Tube actuators that produce bimorph actuation in two directions have been demonstrated at the macroscale [7].

At the microscale, stack and uni/bimorph actuators are difficult to fabricate. Although solder bonding techniques for PZT have been reported [8] stack actuators of more than a few layers have not been fabricated. Low performance AlN and ZnO [4],[9] and thin film PZT unimorph actuators have been made. The PZT films that have been demonstrated, however, do not have the quality of bulk PZT [10] and stress mismatch between the layers during the fabrication results in variably defected structures upon release. Thus, the performance of piezoelectric microactuators can be greatly improved.

Penn State University is well known for pioneering the development of piezoelectric ma-
materials, including high performance, PZT-based, single crystal PMN-PT and PZN-PT that are being produced by a spin-off company in State College. Since coming to PSU in 2000, Dr. Tadigadapa’s research has combined this PZT materials expertise with his MEMS fabrication capabilities to produce innovative microactuators. Novel thin film unimorph [11], unimorph-flextensional [12], and bulk flextensional devices [13] have been fabricated in his laboratory. Dr. Rahn has collaborated with Dr. Tadigadapa to develop advanced, experimentally-validated models of the MEMS bulk flextensional devices [14][15] that enable model-based design and optimization.

Recently, Dr. Tadigadapa developed a new fabrication process that applies Inductively Coupled Reactive Ion Etching (ICP-RIE) directly to PZT to produce structures with vertical walls and flat faces [16]. Using multiple front and backside masks, ICP-RIE etches at various depths can produce a stair-stepped structure from the PZT or single crystal PMN/PZN-PT wafers (Minimum thickness = 100 μm). Masked metallization provides ground and power electrodes that activate specific areas in the structure to enable truly revolutionary MEMS devices. Dr. Tadigadapa has dedicated an RIE machine to this unique process—a process that is perfectly suited to the development of Nano Air Vehicle (NAV) airframes.

There is considerable interest in the development of NAVs for military operations. Current UAVs are too large to penetrate buildings for situational awareness and reconnaissance, emplacement of important sensors, and the sample/return of material. While a variety of Micro Air Vehicles have been built and flown that use propellers and flapping wings for lift generation, NAVs, defined as weighing less than 10 grams with wingspans less than 7.5 cm, have yet to be flown. Significant challenges remain in miniaturizing power, control, and communications, and, most importantly, NAV-scale actuators and wings with the requisite range of motion, power, and efficiency do not exist.

This final report for an AFOSR seed grant describes a new type of monolithic microactuator fabricated from bulk PZT by micro-machining using ICP-RIE process. Using this process we show that a two axis bimorph can be fabricated from a bulk PZT wafer. This
T-beam actuator is fabricated and experimentally shown to produce out-of-plane displacement. Model-based analysis shows that the T-beam actuator geometry can be optimized to produce large displacement and blocking force.

2 A NOVEL PZT FABRICATION PROCESS

The first step in the ICP-RIE fabrication process involves lithographical patterning of a seed layer of Au/Cr onto fine lap finished PZT-4 substrates followed by electro-deposition of
Figure 2: T-beam actuator concept: (a) As fabricated, and deflected shapes when voltage is applied between (b) flanges and bottom electrode, (c) web and bottom electrodes, (d) left flange and bottom electrodes, and (e) right flange and bottom electrodes.
18-22 μm thick nickel and chemical etching of the seed layer. The nickel acts as a hard mask during the etching process. A maximum etch rate of 19 to 25 μm/hr on PZT is obtained using 2000 W of ICP power, 475 W of substrate power, 5 sccm of sulphur hexafluoride (SF₆), and 50 sccm of argon (Ar) on the PZT substrate. This high etch rate makes it possible to machine complex structures monolithically from PZT substrates. Multiple masks and etching from both top and bottom can produce stair stepped structures with arbitrary in-plane shapes.

Fig. 1 shows the fabrication process for an example structure with a T-shaped cross-section. The figure shows a cross-sectional view for the realization of the structure via the etching process. One inch square and 100 μm thick double side polished PZT substrate is the starting material for the T-beam actuators. The cleaned PZT substrate is coated with 500 Å of chromium, followed by a 2000 Å layer of gold as shown in Fig. 1(a). Using an aligner, the Cr/Au seed layer is patterned and electroplated with a thick 18-22 μm Ni hard mask layer (Fig. 1(b)). This is followed by the deep etching of the piezoelectric material to realize the T-shaped structure (Fig. 1(c)). Then, Cr/Au electrodes are coated on the top of the web and flange (Fig. 1(d)). The structures can then be released from the substrate either by a second through etch or by using a dicing saw.

3 THE T-BEAM ACTUATOR CONCEPT

The previous section shows that a T-shaped structure can be fabricated and electroded using the ICP-RIE process. In this section we show that a T-beam actuator fabricated using this process, can provide bimorph actuation in two directions. The T-beam actuator is cantilevered and has a T-shaped cross-section as shown in Fig. 2. The entire T-beam is PZT with electrodes deposited on the top of the web, the top of each flange, and the bottom of the flange. The PZT is poled through-the-thickness from top to bottom.

Fig. 2 shows that the T-beam actuator can be bent both in-plane and out-of-plane by selectively activating the various electrodes. The bottom electrode acts as a ground. Out-
of-plane motion can be achieved by applying voltage to the web electrode or to both flange electrodes. To maximize displacement we operate at maximum field in the direction of poling. Thus, for maximum deflection we actuate the web electrode at $V_w = h \phi_{\text{max}}^+$ where $h$ is the T-beam thickness and $\phi_{\text{max}}^+$ is the maximum field in the direction of poling. The web expands through the thickness and contracts longitudinally, through the $d_{31}$ piezoelectric effect. The inactive flange constrains the lower part of the T-beam, acting as the passive layer in a bimorph design, and the beam bends upward (see Fig. 2(b)). Alternatively, if the two flanges contract due to actuation with $V = t_0 \phi_{\text{max}}^-$, then the web resists contraction and the T-beam bends downward (see Fig. 2(c)). The upward and downward displacement could be further increased by applying negative (rather than zero) voltage to the flanges ($V_G = -t_0 \phi_{\text{max}}^-$) and web ($V_W = -h \phi_{\text{max}}^-$), respectively, effectively configuring it into a bimorph actuator. The maximum negative field ($\phi_{\text{max}}^-$), however, is typically limited to $\phi_{\text{max}}^- \approx \phi_{\text{max}}^+/3$. Hence, the bimorph T-beam design wherein maximum field can be applied for both upward and downward motion provides much larger displacement than with a single active layer.

The T-beam can also provide in-plane displacement by differential application of voltage to the two flanges. To bend left as shown in Fig. 2(d), the left flange electrode is actuated
at \( V_G = t\phi_{\text{max}}^+ \) and the right flange electrode has \( V_G = -t\phi_{\text{max}}^- \). To bend right, the left and right flange electrode voltages are switched (see Fig. 2(e)).

4 EXPERIMENTAL RESULTS

To investigate the feasibility of the T-beam concept, we fabricate the T-beam shown in Fig. 3. The parameters of the fabricated T-beam are shown in Tab. 1. The T-beam is etched to a depth of 17 \( \mu \text{m} \) and released using a dicing saw. The T-beam is actuated by grounding the bottom electrode and applying voltage to the web electrode. The displacement of the T-beam actuator is measured using a laser vibrometer as a function of applied voltage. Fig. 5 shows the experimental displacement \( \Delta \) versus applied voltage up to 270 V. The 8 mm long actuator produces a maximum displacement of 21.52 \( \mu \text{m} \).

5 MATHEMATICAL MODELING

![Graph showing force vs displacement for T-beam model](image)

Figure 4: T-beam model: (a) the initial and deflected shape and (b) cross section

To optimize the performance of the T-beam actuator, we develop a model to predict out-of-plane displacement and blocking force. The T-beam actuator with the web and flange
electrodes shown in Fig. 4 is modeled as a cantilever beam using Euler-Bernoulli beam theory. Fig. 4(a) shows a schematic of the initial and deflected shapes of the T-beam actuator. The Cartesian coordinates $x$ and $z$ denote the horizontal and vertical position of the material particles, respectively. The variables $u$ and $w$ denote the displacements in the longitudinal and transverse directions, respectively. The cross-section of the T-beam shown in Fig. 4(b) has a flange width $s$, flange thickness $t$, web thickness $b$, and overall thickness $h$. The centroidal axis is at a distance

$$e = \frac{1}{2} \frac{t^2 s - t^2 b + 2 t b h - b h^2}{ts - tb + bh}.$$  \hspace{1cm} (1)

below the top of the flange. Voltage is applied between the web ($V_W$) or the two flange electrodes ($V_G$) and the bottom electrode. We assume a uni-axial electric field through the thickness of actuator as shown in Fig. 4(b). $V_W$ and $V_G$ are assumed to produce uniform fields only in the web and flanges, respectively. The potential energy is

$$U_b = \int_{V_b} \frac{E}{2} \left( \frac{\partial u(x)}{\partial x} - z \left( \frac{\partial^2 w(x)}{\partial x^2} \right) \right)^2 dV,$$

$$U_p = \int_{V_p} H dV,$$$$

U = U_b + U_p,$$

where $E$ is the Young’s modulus of PZT, $U_b$, $U_p$ are the potential energy of the passive region and active region, respectively, and $U$ is the total potential energy of the T-beam actuator.

The electric enthalpy $H$ for the active piezoelectric material is given by

$$H = \frac{E}{2} \left( \frac{\partial u(x)}{\partial x} \right)^2 + a_2 z^2 + a_{3M} \left( \frac{\partial^2 w(x)}{\partial x^2} \right)^2 + a_{4M} \frac{\partial^2 w(x)}{\partial x^2} + a_{5M} - (a_{6W} - 2a_{2M} z) \frac{\partial^2 w(x)}{\partial x^2} \frac{\partial u(x)}{\partial x} + a_{8M} \frac{\partial u(x)}{\partial x}.$$  \hspace{1cm} (2)
Table 1: Parameters for T-beam actuator

<table>
<thead>
<tr>
<th>Description</th>
<th>Value</th>
</tr>
</thead>
<tbody>
<tr>
<td>Young's modulus of PZT, $E$ (GPa)</td>
<td>78</td>
</tr>
<tr>
<td>Flange thickness, $t$ ($\mu$m)</td>
<td>83</td>
</tr>
<tr>
<td>Web width, $b$ (mm)</td>
<td>1</td>
</tr>
<tr>
<td>Flange width, $s$ (mm)</td>
<td>6</td>
</tr>
<tr>
<td>Actuator thickness, $h$ ($\mu$m)</td>
<td>100</td>
</tr>
<tr>
<td>Actuator length, $L$ (mm)</td>
<td>8</td>
</tr>
<tr>
<td>Piezoelectric strain coefficient, $d_{31}$ (C/N)</td>
<td>-122e-12</td>
</tr>
<tr>
<td>Permittivity of PZT, $\varepsilon_{33}$ ($C^2/(Nm^2)$)</td>
<td>1.15105e-08</td>
</tr>
</tbody>
</table>

Table 2: Area and moment of inertia for web actuation

<table>
<thead>
<tr>
<th>Region</th>
<th>Area $A$</th>
<th>Moment of inertia $I_{pe}$</th>
</tr>
</thead>
<tbody>
<tr>
<td>Flange</td>
<td>$A_b = (s-b)t$</td>
<td>$I_{be} = \frac{1}{8} t (t^2 + 3e^2 - 3et) (s-b)$</td>
</tr>
<tr>
<td>Web</td>
<td>$A_p = bh$</td>
<td>$I_{pe} = \frac{bh^3}{12} + bh \left(\frac{h}{2} - t + e\right)^2$</td>
</tr>
</tbody>
</table>

where $\varepsilon_{31}$ is piezoelectric stress coefficient, $\varepsilon_{33}$ is the permittivity of PZT, $M = W,G$ for web and flange actuation, respectively [5]. The coefficients in Eq. (3) are given by

$$
\begin{align*}
  a_2 &= \frac{1}{2} \left( \frac{E + \varepsilon_{31}^2}{\varepsilon_{33}} \right),
  a_{3W} = -\frac{\varepsilon_{31}^2 (2e + h - 2t)^2}{8\varepsilon_{33}},
  a_{4W} = -\frac{\varepsilon_{31} V_W (2e + h - 2t)}{2h},
  a_{5W} = -\frac{\varepsilon_{31} V_W^2}{2h^2},
  a_{6W} = \frac{\varepsilon_{31}^2 (2e + h - 2t)}{2\varepsilon_{33}},
  a_{7W} = \frac{\varepsilon_{31} V_W (2e + h - 2t)}{2h},
  a_{8W} = -\frac{\varepsilon_{31} V_W^2}{2h},
  a_{3G} = -\frac{\varepsilon_{33} V_G^2}{8\varepsilon_{33}},
  a_{4G} = -\frac{\varepsilon_{31} V_G (2e + h - 2t)}{2t},
  a_{5G} = \frac{\varepsilon_{33} V_G^2}{2t},
  a_{6G} = \frac{\varepsilon_{31}^2 (2e - t)}{2\varepsilon_{33}},
  a_{8G} = \frac{\varepsilon_{31} V_G}{2t}.
\end{align*}
$$

Substitution of Eqs. (2) into the principle of virtual work, $\int_0^t (\delta U + F\delta w(L))dt = 0$, pro-